

Notice of References Cited	Application/Control No. 10/664,883	Applicant(s)/Patent Under Reexamination FUKUZAWA ET AL.	
	Examiner Robert Hodge	Art Unit 1745	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,618,641	04-1997	Arias, Jeffrey L.	429/210
	B	US-			
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	I	US-			
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	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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